

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY. KET NO. IS15-00		SERIAL NO. 10/525,881	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)					APPLICANT Tatsuya Matsui, et al.			
					FILING DATE February 24, 2005		GROUP Unknown	
U.S. PATENT DOCUMENTS								
Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
	AA							
	AB							
	AC							
	AD							
	AE							
	AF							
	AG							
	AH							
	AJ							
	AJ							
	AK							
	AL							
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
/AWS/	AM	EP 399962 A1	11/28/90	EPO				
/AWS/	AN	JP 2002-166375	6/11/02	Japan				X
/AWS/	AO	JP 5-317145	12/3/93	Japan				X
/AWS/	AP	JP 11-179063	7/06/99	Japan				X
/AWS/	AQ	JP 2002-63505	2/28/02	Japan				X
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
	AR							
	AS							
EXAMINER					DATE CONSIDERED			
/Andrew W. Sutton/					07/22/2007			
*EXAMINER: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								

EV550719408

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY. FEE NO. IS15-00		SERIAL NO. 10/525,881	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)					APPLICANT Tatsuya Matsui, et al.			
					FILING DATE February 24, 2005		GROUP Unknown	
U.S. PATENT DOCUMENTS								
Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
	AA							
	AB							
	AC							
	AD							
	AE							
	AF							
	AG							
	AH							
	AI							
	AJ							
	AK							
	AL							
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
/AWS/	AM	JP 5-269260	10/19/93	Japan				X
/AWS/	AN	JP 7-104692	4/21/95	Japan				X
/AWS/	AO	JP 53-91499	7/26/78	Japan				X
	AP							
	AQ							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
	AR							
	AS							
EXAMINER					DATE CONSIDERED			
/Andrew W. Sutton/					07/22/2007			
*EXAMINER: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								